


<b>Search Notes</b>  	<b>Application/Control No.</b>  10792099	<b>Applicant(s)/Patent Under Reexamination</b>  SCOTT ET AL.
	<b>Examiner</b>  Hanh Nguyen	<b>Art Unit</b>  2416

SEARCHED			
Class	Subclass	Date	Examiner
370	389	11/17/08	hn
370	401		
370	352		
370	465		
370	466		
370	467		
370	395.5		
370	410		
370	426		
370	522		
370	524		
379	201.01		
379	210.02	11/17/08	hn

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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